

Search Notes

Application/Control No.

10/827,313

Examiner

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Applicant(s)/Patent under
Reexamination

YAMAOKA ET AL.

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
123	90.11	7/13/2005	HHH
123	90.15	7/13/2005	HHH
123	305	7/13/2005	HHH
123	318	7/13/2005	HHH
123	406.11	7/13/2005	HHH
123	406.45	7/13/2005	HHH
123	406.48	7/13/2005	HHH
123	435	7/13/2005	HHH
123	672	7/13/2005	HHH
123	568.11	7/13/2005	HHH
123	568.14	7/13/2005	HHH
123	299	7/13/2005	HHH
123	399	7/13/2005	HHH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	7/13/2005	HHH